

FQPF11P06

60V P-Channel MOSFET

General Description

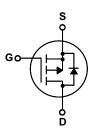
These P-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand a high energy pulse in the avalanche and commutation modes. These devices are well suited for low voltage applications such as automotive, DC/DC converters, and high efficiency switching for power management in portable and battery operated products.

Features

- -8.6A, -60V, $R_{DS(on)}$ = 0.175 Ω @V_{GS} = -10 V Low gate charge (typical 13 nC)
- Low Crss (typical 45 pF)
- Fast switching
- · 100% avalanche tested
- · Improved dv/dt capability
- 175°C maximum junction temperature rating





Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		FQPF11P06	Units
V _{DSS}	Drain-Source Voltage		-60	V
I _D	Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C)		-8.6	А
			-6.08	А
I _{DM}	Drain Current - Pulsed	(Note 1)	-34.4	Α
V _{GSS}	Gate-Source Voltage		± 25	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	160	mJ
I _{AR}	Avalanche Current	(Note 1)	-8.6	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	3.0	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	-7.0	V/ns
P_{D}	Power Dissipation (T _C = 25°C)		30	W
	- Derate above 25°C		0.2	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +175	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		5.0	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

Symbol	Parameter	Test Conditions		Min	Тур	Max	Units
Off Cha	aracteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-60			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = -250 μA, Referenced	to 25°C		-0.07		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -60 V, V _{GS} = 0 V				-1	μΑ
		V _{DS} = -48 V, T _C = 150°C			-	-10	μА
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = -25 V, V _{DS} = 0 V			-	-100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = 25 V, V _{DS} = 0 V			-	100	nA
On Cha	racteristics						
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$		-2.0		-4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = -10 V, I _D = -4.3 A			0.14	0.175	Ω
9 _{FS}	Forward Transconductance	V _{DS} = -30 V, I _D = -4.3 A	(Note 4)		4.75		S
C _{iss}	Input Capacitance Output Capacitance	$V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz			420 195	550 250	pF pF
C _{rss}	Reverse Transfer Capacitance				45	60	pF
0 11 11							
	ing Characteristics	1			0.5	0.5	
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -30 \text{ V}, I_{D} = -5.7 \text{ A},$ $R_{G} = 25 \Omega$ (Note 4, 5)			6.5	25	ns
t _r	Turn-On Rise Time				40	90	ns
t _{d(off)}	Turn-Off Delay Time				15	40	ns
t _f	Turn-Off Fall Time		, , , ,		45	100	ns
Q _g	Total Gate Charge	$V_{DS} = -48 \text{ V}, I_{D} = -11.4 \text{ A},$			13	17	nC
Q _{gs}	Gate-Source Charge	V _{GS} = -10 V			2.0 6.3		nC nC
Q _{gd}	Gate-Drain Charge		Note 4, 5)		0.3		IIC
Drain-S	Source Diode Characteristics ar	nd Maximum Ratings					
I _S	Maximum Continuous Drain-Source Diode Forward Current					-8.6	Α
I _{SM}	Maximum Pulsed Drain-Source Diode F	e Forward Current				-34.4	Α
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -8.6 \text{ A}$			-	-4.0	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_{S} = -11.4 \text{ A},$			83		ns
Q _{rr}	Reverse Recovery Charge	dI _F / dt = 100 A/μs	(Note 4)		0.26		μС

- Notes: 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 2.5mH, $|_{AS}$ = -8.6A, V_{DD} = -25V, R_G = 25 Ω , Starting T_J = 25°C 3. $|_{SD}$ < =1.4A, didt < 300A $|_{LS}$, V_{DD} < E_{DS} , Starting E_{LS} < E_{LS} < 0.4 Pulse Test : Pulse width < 300 E_{LS} . Duty cycle < 2% 5. Essentially independent of operating temperature

Typical Characteristics

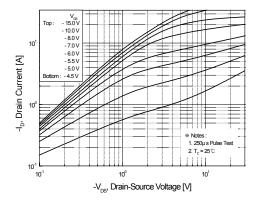


Figure 1. On-Region Characteristics

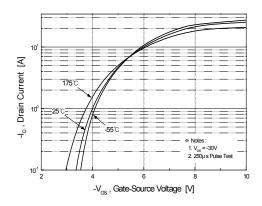


Figure 2. Transfer Characteristics

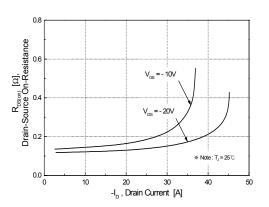


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

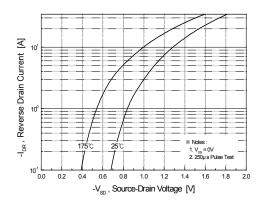


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

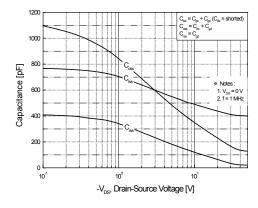


Figure 5. Capacitance Characteristics

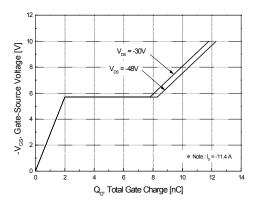
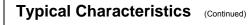
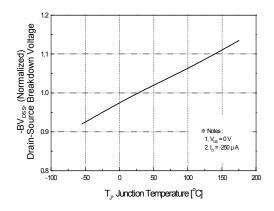


Figure 6. Gate Charge Characteristics

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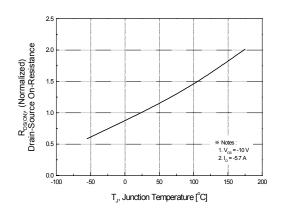
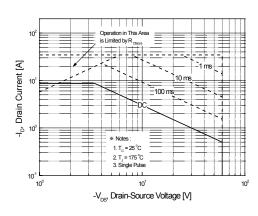


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



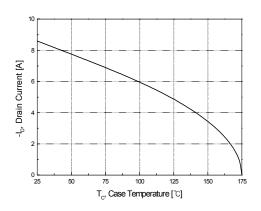


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

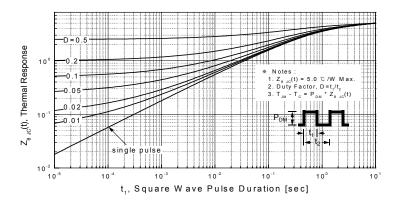
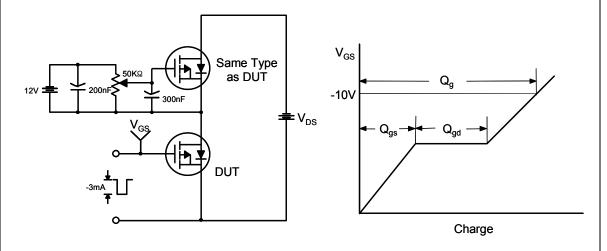
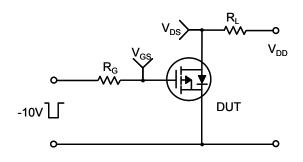


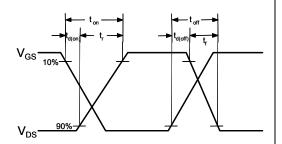
Figure 11. Transient Thermal Response Curve

Gate Charge Test Circuit & Waveform

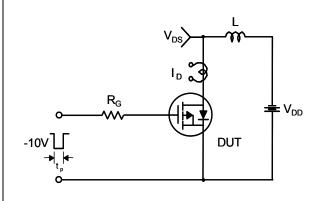


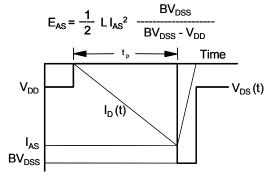
Resistive Switching Test Circuit & Waveforms



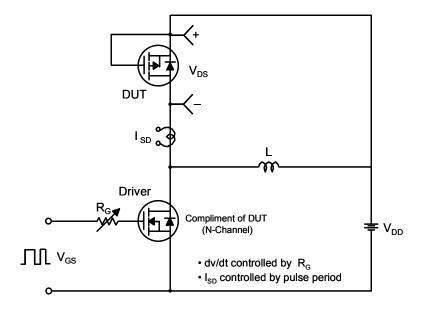


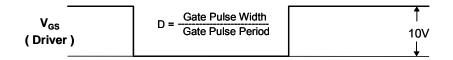
Unclamped Inductive Switching Test Circuit & Waveforms

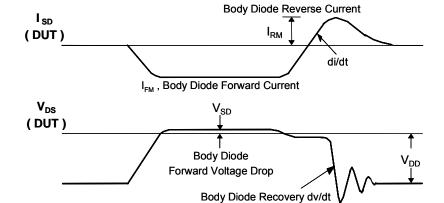


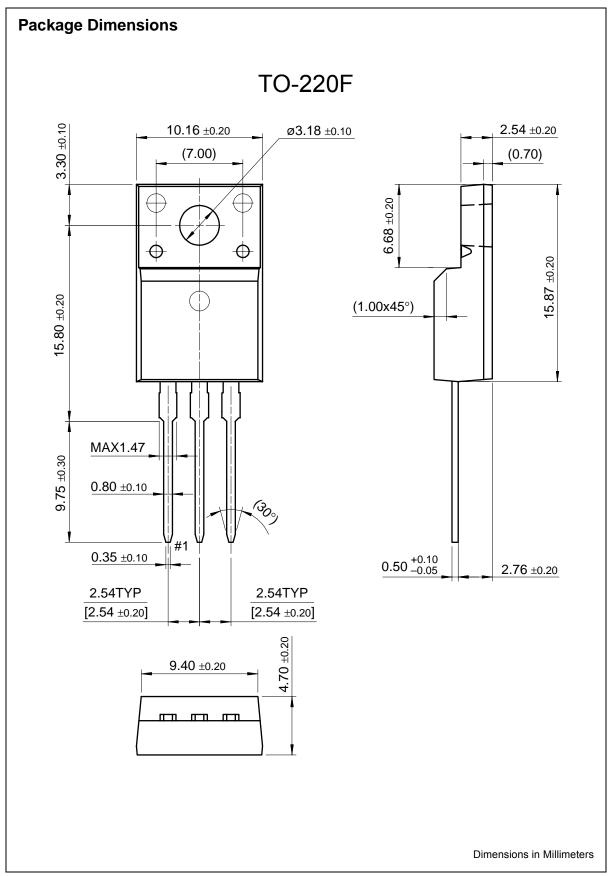


Peak Diode Recovery dv/dt Test Circuit & Waveforms









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